Substitute for form 1449/PTO (Revised 07/2007)				Complete if Known									
				International Appl. No. PCT/U			PCT/US2004/0	/US2004/042706					
(Revised 07/	2007)				In	ternational F	ile D	ate	December 20, 2	2004	1		
INFORMATION DISCLOSURE				A	Application Number			10/583,570					
	INFORMATION DISCLOSURE					First Named Inventor			DeSimone				
STATEMENT BY APPLICANT (Use as many sheets as necessary)					Art Unit			1617					
						caminer Nan			Sheikh, H.				
Sheet	11		of	1	Attorney Docket Number 0			035052/338899					
U. S. PATENT DOCUMENTS													
		Document Number											
Examiner Initials*	xaminer Cite initials* No.		N. 1. W. 16 1 (6)						e of Patentee or t of Cited Document		Pages, Columns, Lines, Where Relevant Passages of Relevant Figures		
muais.	No.	Number - Kind Code (if known)			IVIN	MM-DD-YYYY Applicant		Appear					
/J.W./	196	US-4	,818,801		04-	04-1989		Rice.	, D.E., et al.	T			
/J.W./	197	US-2002/0172895			11-	11-21-2002 Breen			ı, T.L., et al.	П			
				FOD	EIC	N PATENT	· DO	CUME	NTC				
			Essaion Data		EIG	NPALENI	DU	CUME	4112	Dan	es, Columns, Lines,	English	
Evaminer	Cite	Cite	Toleigh Fale	Foreign Patent Document			Publication Date N		Name of Patentee or		Where Relevant	Language	
Examiner Initials	No.	Country Code - Number Kind Code									ssages or Relevant	Translation	
		(if known)						Docume			Figures Appear	Attached	
							_						

	BAILEY, T., et al. "Step and Flash Imprint Lithography: Template Surface Treatment and Defect Analysis," J. Vac. Sci. Technol. B, 2000, pp. 3572-3577, Vol. 18(6).	
19	9 H	

Examiner	/Jessica Worsham/	Date	06/10/2011	
Signature		Considered		_

^{*}Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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